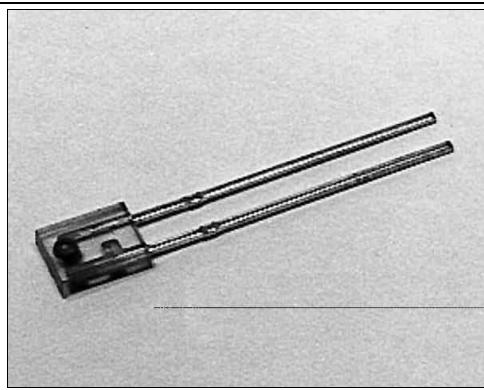


# SDP8406

## Silicon Phototransistor

### FEATURES

- Side-looking plastic package
- 50° (nominal) acceptance angle
- Wide sensitivity ranges
- Mechanically and spectrally matched to SEP8506 and SEP8706 infrared emitting diodes

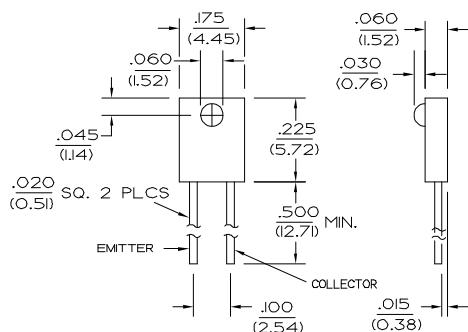


### DESCRIPTION

The SDP8406 is an NPN silicon phototransistor molded in a side-looking clear plastic package. The chip is positioned to accept radiation through a plastic lens from the side of the package.

### OUTLINE DIMENSIONS in inches (mm)

Tolerance	3 plc decimals	$\pm 0.005(0.12)$
	2 plc decimals	$\pm 0.020(0.51)$



DIM\_017.cdr

# SDP8406

Silicon Phototransistor

## ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS
Light Current SDP8406-001	$I_L$	0.15	1.90		mA	$V_{CE}=5\text{ V}$ $H=1\text{ mW/cm}^2$ (1)
SDP8406-002		1.80	3.60			
SDP8406-003		3.40	6.50			
SDP8406-004		6.40	12.0			
Collector Dark Current	$I_{CEO}$		100		nA	$V_{CE}=15\text{ V}$ , $H=0$
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	30			V	$I_C=100\text{ }\mu\text{A}$
Emitter-Collector Breakdown Voltage	$V_{(BR)ECO}$	5.0			V	$I_E=100\text{ }\mu\text{A}$
Collector-Emitter Saturation Voltage	$V_{CE(SAT)}$		0.4		V	$I_C=I_L/8$ $H=1\text{ mW/cm}^2$
Angular Response (2)	$\emptyset$		50		degr.	$I_F=\text{Constant}$
Rise And Fall Time	$t_r, t_f$		15		μs	$V_{CC}=5\text{ V}$ , $I_L=1\text{ mA}$ $R_L=1000\text{ }\Omega$

Notes

1. The radiation source is an IRED with a peak wavelength of 935 nm.
2. Angular response is defined as the total included angle between the half sensitivity points.

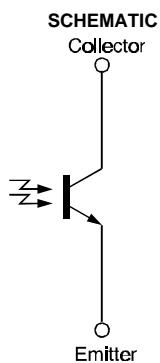
## ABSOLUTE MAXIMUM RATINGS

(25°C Free-Air Temperature unless otherwise noted)

Collector-Emitter Voltage	30 V
Emitter-Collector Voltage	5 V
Power Dissipation	100 mW (1)
Operating Temperature Range	-40°C to 85°C
Storage Temperature Range	-40°C to 85°C
Soldering Temperature (5 sec)	240°C

Notes

1. Derate linearly from 25°C free-air temperature at the rate of 0.78 mW/°C.



Honeywell reserves the right to make changes in order to improve design and supply the best products possible.

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# SDP8406

Silicon Phototransistor

**SWITCHING TIME TEST CIRCUIT**

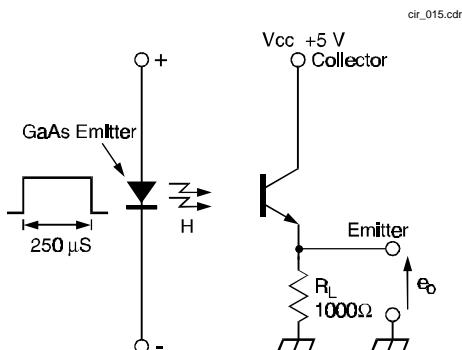
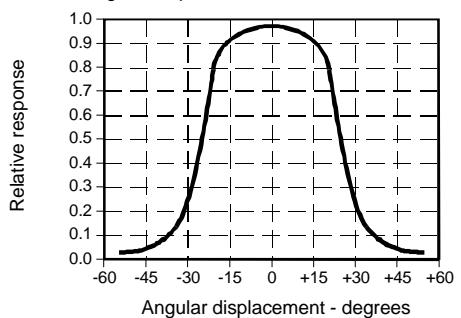


Fig. 1 Responsivity vs Angular Displacement



**SWITCHING WAVEFORM**

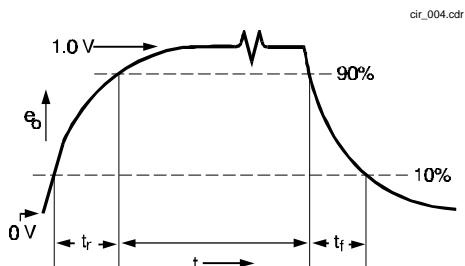


Fig. 2 Collector Current vs Ambient Temperature

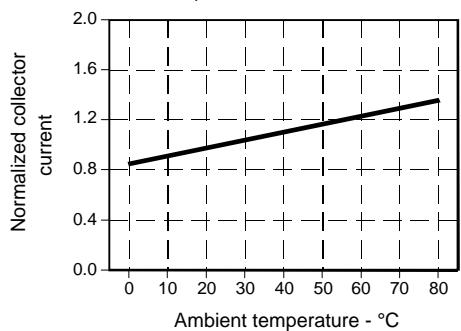


Fig. 3 Dark Current vs Temperature

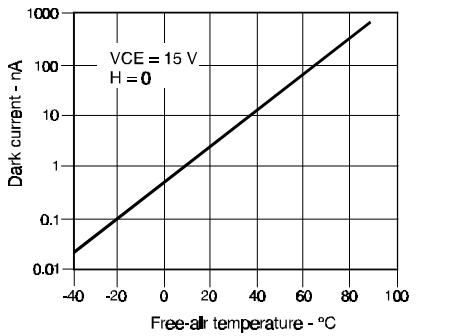
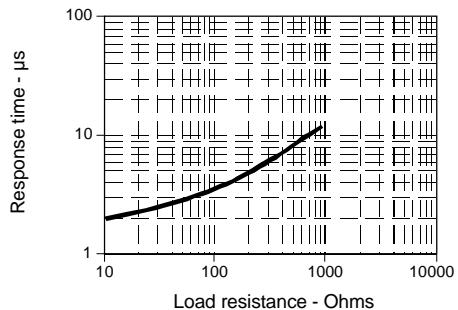


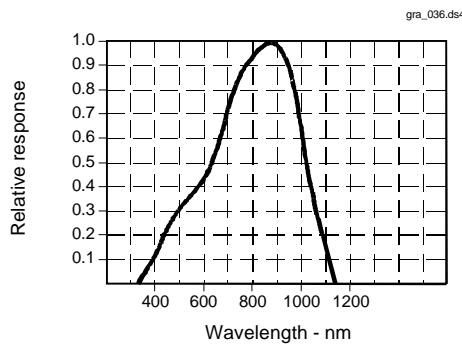
Fig. 4 Non-Saturated Switching Time vs Load Resistance



# SDP8406

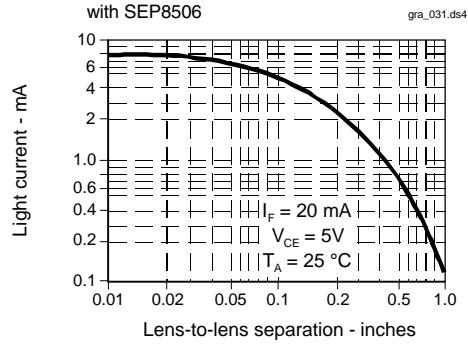
## Silicon Phototransistor

Fig. 5 Spectral Responsivity



All Performance Curves Show Typical Values

Fig. 6 Coupling Characteristics with SEP8506



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